Search Notes



Application/Control No.

10670787

HAN ET AL.

Reexamination

Applicant(s)/Patent Under

Examiner

Han, Jason M

Art Unit

2875

SEARCHED

01			
Class	Subclass	Date	Examiner

SEARC	H NOTES
-------	---------

Search Notes	Date	Examiner
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	10/25/2006	JMH
Search Update - EAST (US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB) - See Printout	5/8/2007	JMH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	,		

U.S. Patent and Trademark Office

Part of Paper No.: 20070508